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TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MZ4051FK,TC7MZ4052FK,TC7MZ4053FK

TC7MZ4051FK 8-Channel Analog Multiplexer/Demultiplexer TC7MZ4052FK Dual 4-Channel Analog Multiplexer/Demultiplexer TC7MZ4053FK Triple 2-Channel Analog

Multiplexer/Demultiplexer

The TC7MZ4051/4052/4053FK are high-speed, low-voltage drive analog multiplexer/demultiplexers using silicon gate CMOS technology. In 3 V and 5 V systems these can achieve high-speed operation with the low power dissipation that is a feature of CMOS.

The TC7MZ4051/4052/4053FK offer analog/digital signal selection as well as mixed signals. The 4051 has an 8-channel configuration, the 4052 has an 4-channel × 2 configuration, and the 4053 has a 2-channel × 3 configuration.

The switches for each channel are turned ON by the control pin digital signals.

Although the control signal logical amplitude (V_{CC} – GND) is small, the device can perform large-amplitude (V_{CC} – V_{EE}) signal switching.

For example, if $V_{CC} = 3 \text{ V}$, GND = 0 V, and $V_{EE} = -3 \text{ V}$, signals between -3 V and +3 V can be switched from the logical circuit using a single 3 V power supply.

All input pins are equipped with a newly developed input protection circuit that avoids the need for a diode on the plus side (forward side from the input to the V_{CC}). As a result, for example, 5 V signals can be permitted on the inputs even when the power supply voltage to the circuits is off. As a result of this input power protection, the TC7MZ4051/4052/4053FK can be used in a variety of applications, including in the system which has two power supplies, and in battery backup circuits.

Features

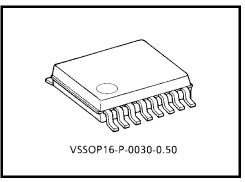
• Low ON resistance: $R_{on} = 22 \Omega$ (typ.) ($V_{CC} - V_{EE} = 3 V$)

 $R_{on} = 15 \ \Omega \ (typ.) \ (V_{CC} - V_{EE} = 6 \ V)$

- High speed: $t_{pd} = 3 \text{ ns} (typ.) (V_{CC} = 3.0 \text{ V})$
- Low power dissipation: $I_{CC} = 4 \ \mu A \ (max) \ (Ta = 25^{\circ}C)$
- Input level: $V_{IL} = 0.8 V (max) (V_{CC} = 3 V)$

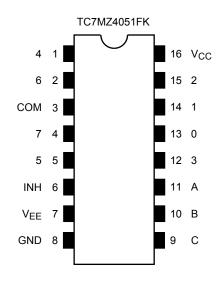
$$V_{IH} = 2.0 V (min) (V_{CC} = 3 V)$$

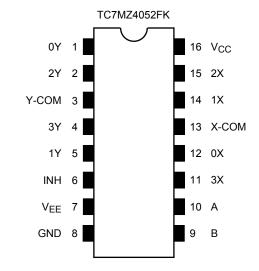
- Power down protection is provided on all control inputs
- Pin and function compatible with 74HC4051/4052/4053

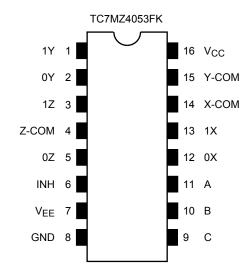


Weight: 0.02 g (typ.)

Pin Assignment (top view)







Truth Table

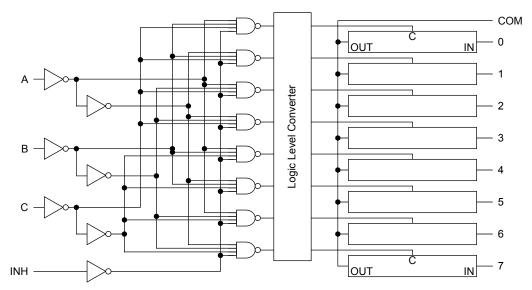
	Contro	l Inputs		"ON" Channel				
Inhibit	C*	В	А	MZ4051FK	MZ4052FK	MZ4053FK		
L	L	L	L	0	0X, 0Y	0X, 0Y, 0Z		
L	L	L	Н	1	1X, 1Y	1X, 0Y, 0Z		
L	L	Н	L	2	2X, 2Y	0X, 1Y, 0Z		
L	L	Н	Н	3	3X, 3Y	1X, 1Y, 0Z		
L	Н	L	L	4	—	0X, 0Y, 1Z		
L	Н	L	Н	5	—	1X, 0Y, 1Z		
L	Н	Н	L	6	—	0X, 1Y, 1Z		
L	Н	Н	Н	7	—	1X, 1Y, 1Z		
Н	Х	Х	Х	None	None	None		

X: Don't care, *: Except MZ4052FK

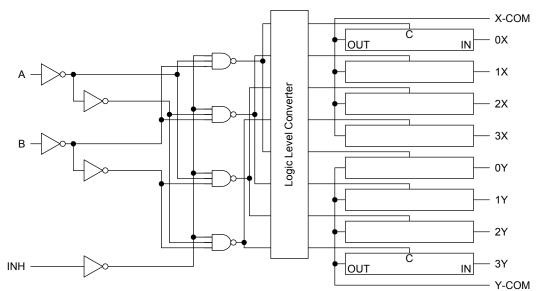
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System Diagram

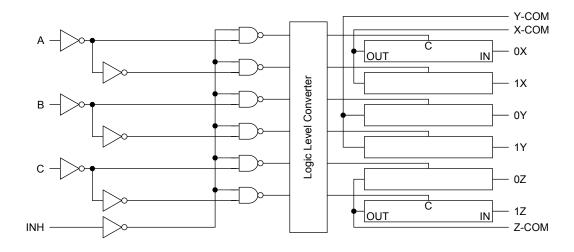
TC7MZ4051FK



TC7MZ4052FK



TC7MZ4053FK



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V _{CC}	-0.5~7.0	V	
Fower supply voltage	V _{CC} ~V _{EE}	-0.5~7.0		
Control input voltage	V _{IN}	-0.5~7.0	V	
Switch I/O voltage	V _{I/O}	$V_{EE} - 0.5 V_{CC} + 0.5$	V	
Input diode current	I _{IK}	-20	mA	
I/O diode current	liok	±20	mA	
Switch through current	Ι _Τ	±25	mA	
DC V _{CC} or ground current	ICC	±50	mA	
Power dissipation	PD	180	mW	
Storage temperature	T _{stg}	-65~150	°C	

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
	V _{CC}	2~6	
Power supply voltage	V _{EE}	-4~0	V
	V _{CC} ~V _{EE}	2~6	
Input voltage	V _{IN}	0~6.0	V
Switch I/O voltage	V _{I/O}	V _{EE} ~V _{CC}	V
Operating temperature	T _{opr}	-40~85	°C
Input rise and fall time	dt/dv	0~100 (V_{CC} = 3.3 \pm 0.3 V)	ns/V
input rise and fair time	avav	0~20 (V _{CC} = 5 \pm 0.5 V)	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused control inputs must be tied to either V_{CC} or GND.

Electrical Characteristics

DC Electrical Characteristics

Characteristics		Symbol Test Condition				-	Ta = 25°0	C	Ta = -4	Ta = -40~85°C	
Characte			Test Condition	$V_{\text{EE}}(V)$	$V_{CC}\left(V\right)$	Min	Тур.	Max	Min	Max	Unit
					2.0	1.5			1.5		
	High-level	VIH			3.0	2.0	_	_	2.0	_	
	i ligii-level	۷IH			4.5	3.15	_	_	3.15	_	
Input voltage					6.0	4.2			4.2		V
input voitage					2.0			0.5	_	0.5	v
	Low-level	VIL			3.0			0.8	_	0.8	
	LOW-IEVEI	۷IL			4.5			1.35	_	1.35	
					6.0			1.8	_	1.8	
				GND	2.0		200		_		
		$R_{ON} = V_{I/O} = V_{CO}$ $V_{I/O} = 2 m/$ $V_{IN} = V_{ILO}$ $V_{I/O} = V_{CO}$	$V_{IN} = V_{IL} \text{ or } V_{IH}$	GND	3.0		45	86	_	108	Ω
				GND	4.5		24	37	_	46	
ON resistance			1/0 - 2 11/4	-3.0	3.0		17	26	_	33	
ONTESISIANCE			$V_{IN} = V_{IL} \text{ or } V_{IH}$ $V_{I/O} = V_{CC} \text{ or } V_{EE}$ $I_{I/O} = 2 \text{ mA}$	GND	2.0		28	73		84	
				GND	3.0		22	38	_	44	
				GND	4.5	_	17	27	_	31	
				-3.0	3.0	_	15	24	_	28	
				GND	2.0	_	10	25	_	35	Ω
Difference of O resistance betw		ABass	V _{IN} = V _{IL} or V _{IH} V _{I/O} = V _{CC} to V _{EE}	GND	3.0	_	5	15	_	20	
switches	een		$V_{I/O} = 2 \text{ mA}$	GND	4.5	_	5	13	_	18	52
			1/U – 2 11A	-3.0	3.0	_	5	10	_	15	
Input/Output lea	akade		$V_{OS} = V_{CC} \text{ or } GND$	GND	3.0	_	_	±0.25	_	±2.5	
(switch OFF)		I _{OFF}	$V_{IS} = GND \text{ to } V_{CC}$ $V_{IN} = V_{IL} \text{ or } V_{IH}$	-3.0	3.0	_	_	±0.5	_	±5.0	μA
Input/Output leakage		,	V _{OS} = V _{CC} or GND	GND	3.0			±0.25	_	±2.5	
current (switch ON, out	put open)	lin	$V_{IN} = V_{IL} \text{ or } V_{IH}$	-3.0	3.0	_	_	±0.5	_	±5.0	μA
Control input current		I _{IN}	$V_{IN} = V_{CC}$ or GND	GND	6.0	_		±0.1	_	±0.1	μA
Outeeent	lu aumant			GND	3.0			4.0		40.0	•
Quiescent supp	by current	ICC	$V_{IN} = V_{CC}$ or GND	-3.0	3.0			8.0		80.0	μA

AC Electrical Characteristics ($C_L = 50 \text{ pF}$, Input: $t_r = t_f = 3 \text{ ns}$, GND = 0 V)

Characteristics	Symbol	Та	at Condition			-	Га = 25°С)	Ta = −40~85°C		Unit
Characteristics	Symbol	Test Condition		$V_{\text{EE}}(V)$	$V_{CC}(V)$	Min	Тур.	Max	Min	Max	Unit
		All types		GND	2.0	_	3.2	6.0		6.9	ns
Phase difference between	φl/O			GND	3.0	_	1.8	3.0	_	3.5	
input and output	ψι/Ο			GND	4.5		1.3	1.8		2.1	
				-3.0	3.0	_	1.1	1.3		1.5	
				GND	2.0	_	9.0	17		20	
Output enable time	t _{pZL}	Figure	1 (Note 1)	GND	3.0		5.7	9.0		11	ne
	t _p ZH	rigure		GND	4.5		4.5	6.0		7.0	ns
				-3.0	3.0		5.8	8.0		10	
				GND	2.0	_	13.5	21		25	ns
Output disable time	t _{pLZ}	Figure 1 (Not	1 (Note 1)	GND	3.0		11.3	15		18	
	t _{pHZ}			GND	4.5	_	10.3	12		14	
				-3.0	3.0	_	10.9	13		15	
Control input capacitance	C _{in}	All type	es (Note 2)	_	_	_	5	10		10	pF
		4051	Figure 2			_	11	25		25	
COMMON terminal capacitance	CIS	4052		-3.0	3.0		9	20	—	20	
	$ \begin{array}{c} t_{pZL} \\ t_{pZH} \\ t_{pZH} \\ \end{array} \\ \begin{array}{c} F_{igure 1} \\ F_{igure 1} \\ \end{array} \\ \begin{array}{c} (Note 1) \\ G \\ $				7	15		15	1		
		4051	Eiguro 2)	6	13		13	
SWITCH terminal capacitance	C _{OS}	4052	J	-3.0	3.0		6	13	—	13	pF
		4053					6	13		13	
		4051					3	6		6	
Feedthrough capacitance	C _{IOS}	4052		-3.0	3.0	—	- 3 6	—	6	pF	
		4053	· · · · ·				3	6		6	
		4051	Figure 2 (Note 3)				14	_	1		pF
Power dissipation capacitance	C _{PD}	4052		GND	6.0	—	24		—	—	
		4053	, , ,				18				

Note 1: $R_L = 1 \ k\Omega$

Note 2: C_{in} , C_{IS} , C_{OS} and C_{IOS} are guaranteed by the design.

Note 3: C_{PD} is defined as the value of the internal equivalent capacitance of IC which is calculated from the operating current consumption without load.

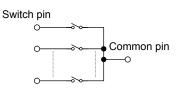
Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

*Analog Switch Characteristics (GND = 0 V, Ta = 25°C)

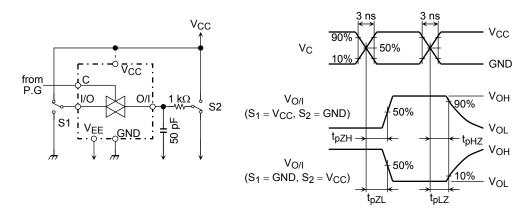
Characteristics	Symbol	Test Condition	_		Typ.	Unit	
Characteristics	Symbol	Test Condition		$V_{EE}(V)$	V _{CC} (V)	тур.	Onic
			$V_{IN} = 2.0 V_{p-p}$	0	3.0	0.100	
Sine Wave Distortion (T.H.D)		$R_L = 10 k\Omega, C_L = 50 pF,$ f _{IN} = 1 kHz	$V_{IN} = 4.0 V_{p-p}$	0	4.5	0.030	%
			V _{IN} = 6.0 V _{p-p}	-0.3	3.0	0.020	
			4051			150	MHz
			4052	0	3.0	180	
		Adjust f _{IN} voltage to obtain 0dBm at V _{OS} .	4053			200	
		Increase f _{IN} frequency until dB	4051			150	
Frequency response (switch ON)	f _{max}	meter reads -3dB.	4052	0	4.5	180	
(Switch ON)		$R_L = 50 \Omega$, $C_L = 10 pF$, $f_{IN} = 1 MHz$, sine wave	4053			200	
		Figure 3	4051		3.0	150	
			4052	-3.0		180	
			4053			200	
		V_{IN} is centered at $(V_{CC} - V_{EE})/2$.	0	3.0	-45	dB	
		Adjust input for 0dBm.		0	4.5		45
		$R_L=600~\Omega,~C_L=50~pF,~f_{IN}=1~M$	-	4.5	-40		
Feed through attenuation (switch OFF)		Figure 4	-3.0	3.0	-45		
· · · ·				0	3.0	-60	
		R_L = 50 Ω , C_L = 10 pF, f_IN = 1 MH	50 Ω , C _L = 10 pF, f _{IN} = 1 MHz, sine wave		4.5	-60	1
				-3.0	3.0	-60	
Crosstalk		$R_L = 600 \ \Omega$, $C_L = 50 \ pF$, $f_{IN} = 1 \ M$	Hz, square wave	0	3.0	90	
(control input to signal	(4		$(t_r = t_f = 6 \text{ ns})$			150	mV
output)		Figure 5		-3.0	3.0	-45 -45 -45 -60 -60 -60 90	
Crosstalk		Adjust V _{IN} to obtain 0dBm at input	0	3.0	-45		
(between any switches)		$R_L=600~\Omega,~C_L=50~pF,~f_{IN}=1~M$	0	4.5	-45	dB	
(Detween any Switches)		Figure 6		-3.0	3.0	-45	

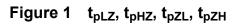
*: These characteristics are determined by design of devices.



<u>TOSHIBA</u>

AC Test Circuit





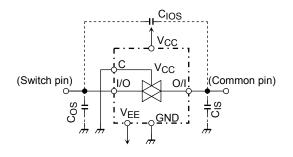
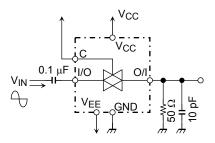


Figure 2 C_{IOS}, C_{IS}, C_{OS}





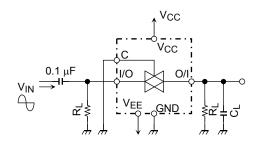
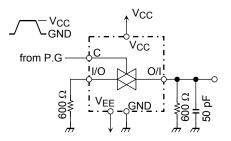
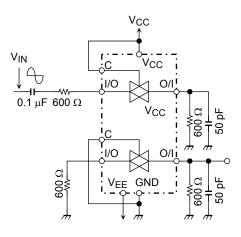


Figure 4 Feedthrough





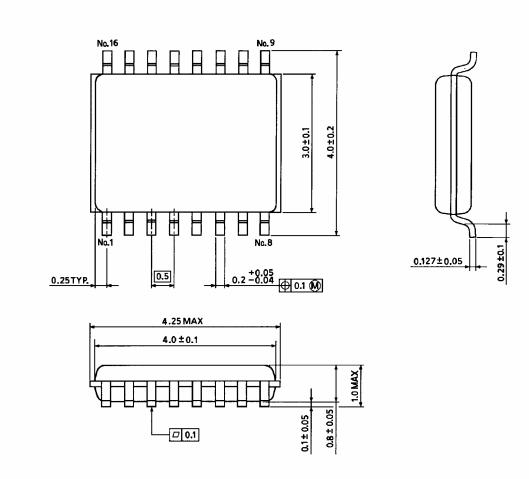




Package Dimensions

VSSOP16-P-0030-0.50

Unit : mm



Weight: 0.02 g (typ.)

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20070701-EN GENERAL

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